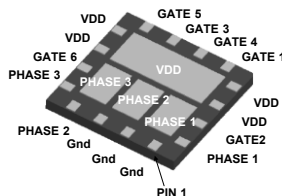
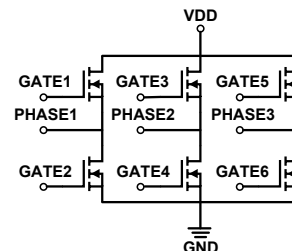


### Main Product Characteristics

$BV_{DSS}$	30V
$R_{DS(ON)}$	8.5m $\Omega$
$I_D$	42A



DFN6x6



Schematic Diagram

### Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



### Description

The GSMP0342 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supply and a wide variety of other applications.

### Absolute Maximum Ratings ( $T_c=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous ( $T_c=25^\circ\text{C}$ )	$I_D$	42	A
Drain Current-Continuous ( $T_c=100^\circ\text{C}$ )		26.6	
Drain Current-Pulsed <sup>1</sup>	$I_{DM}$	168	A
Single Pulse Avalanche Energy <sup>2</sup>	$E_{AS}$	45	mJ
Single Pulse Avalanche Current <sup>2</sup>	$I_{AS}$	30	A
Power Dissipation ( $T_c=25^\circ\text{C}$ )	$P_D$	24.7	W
Power Dissipation-Derate above 25 $^\circ\text{C}$		0.20	
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	5.06	$^\circ\text{C/W}$
Operating Junction Temperature Range	$T_J$	-55 To +150	$^\circ\text{C}$
Storage Temperature Range	$T_{STG}$	-55 To +150	$^\circ\text{C}$

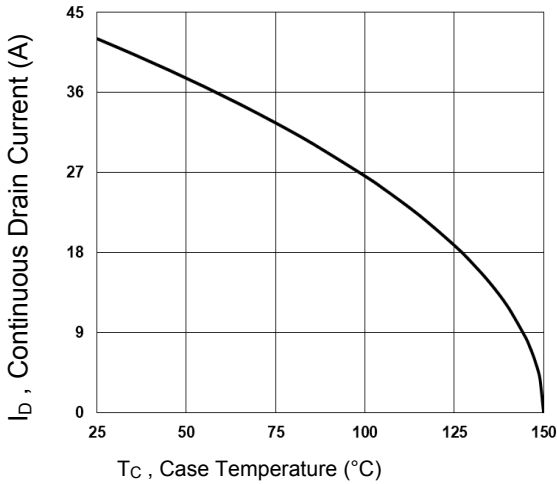
**Electrical Characteristics** ( $T_J=25^{\circ}\text{C}$  unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>On/Off Characteristics</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	30	-	-	V
$BV_{DSS}$ Temperature Coefficient	$\Delta BV_{DSS}/\Delta T_J$	Reference to $25^{\circ}\text{C}$ , $I_D=1mA$	-	0.04	-	$V/^{\circ}\text{C}$
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=30V, V_{GS}=0V, T_J=25^{\circ}\text{C}$	-	-	1	$\mu A$
		$V_{DS}=24V, V_{GS}=0V, T_J=125^{\circ}\text{C}$	-	-	10	
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	$\pm 100$	nA
Static Drain-Source On-Resistance <sup>3</sup>	$R_{DS(ON)}$	$V_{GS}=10V, I_D=16A$	-	7.5	8.5	m $\Omega$
		$V_{GS}=4.5V, I_D=8A$	-	10	13	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1.2	1.6	2.5	V
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}$		-	-4	-	mV/ $^{\circ}\text{C}$
Forward Transconductance	$g_{fs}$	$V_{DS}=10V, I_D=8A$	-	9.5	-	S
<b>Dynamic and Switching Characteristics</b>						
Total Gate Charge <sup>3,4</sup>	$Q_g$	$V_{DS}=15V, I_D=20A,$ $V_{GS}=10V$	-	16.7	33	nC
Gate-Source Charge <sup>3,4</sup>	$Q_{gs}$		-	4.5	8	
Gate-Drain Charge <sup>3,4</sup>	$Q_{gd}$		-	1.3	2.6	
Turn-On Delay Time <sup>3,4</sup>	$t_{d(on)}$	$V_{DD}=15V, R_G=3.3\Omega,$ $V_{GS}=10V, I_D=15A$	-	4.8	9.0	nS
Rise Time <sup>3,4</sup>	$t_r$		-	12.5	24	
Turn-Off Delay Time <sup>3,4</sup>	$t_{d(off)}$		-	27.6	52	
Fall Time <sup>3,4</sup>	$t_f$		-	8.2	16	
Input Capacitance	$C_{iss}$	$V_{DS}=25V, V_{GS}=0V,$ $F=1MHz$	-	850	1700	pF
Output Capacitance	$C_{oss}$		-	130	260	
Reverse Transfer Capacitance	$C_{rss}$		-	78	160	
Gate Resistance	$R_g$	$V_{GS}=0V, V_{DS}=0V, F=1MHz$	-	2.7	5.5	$\Omega$
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
Continuous Source Current	$I_s$	$V_G=V_D=0V, \text{Force Current}$	-	-	42	A
Pulsed Source Current <sup>3</sup>	$I_{SM}$		-	-	84	A
Diode Forward Voltage <sup>3</sup>	$V_{SD}$	$V_{GS}=0V, I_s=1A, T_J=25^{\circ}\text{C}$	-	-	1	V
Reverse Recovery Time	$t_{rr}$	$V_{GS}=0V, I_s=10A,$ $di/dt=100A/\mu s, T_J=25^{\circ}\text{C}$	-	8.1	-	nS
Reverse Recovery Charge	$Q_{rr}$		-	1.6	-	nC

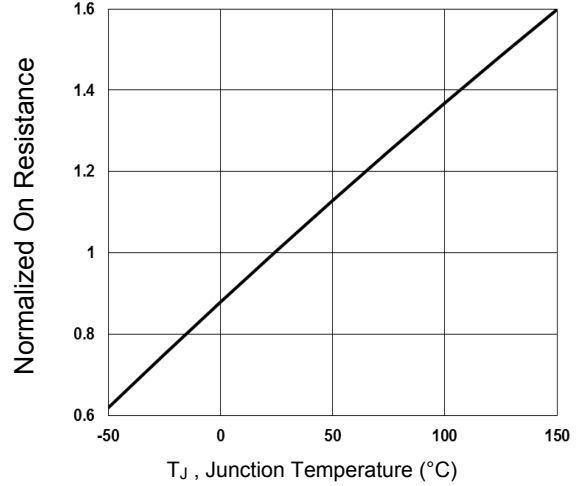
Note:

1. Repetitive rating: Pulsed width limited by maximum junction temperature.
2.  $V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=30A, R_G=25\Omega,$  starting  $T_J=25^{\circ}\text{C}$ .
3. Pulse test: pulse width  $\leq 300\mu s,$  duty cycle  $\leq 2\%$ .
4. Essentially independent of operation temperature.

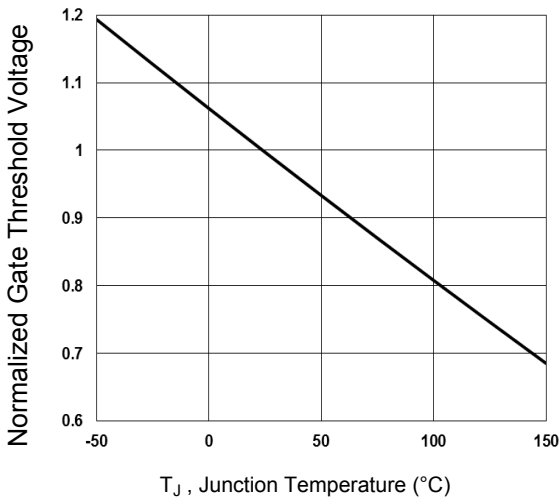
**Typical Electrical and Thermal Characteristic Curves**



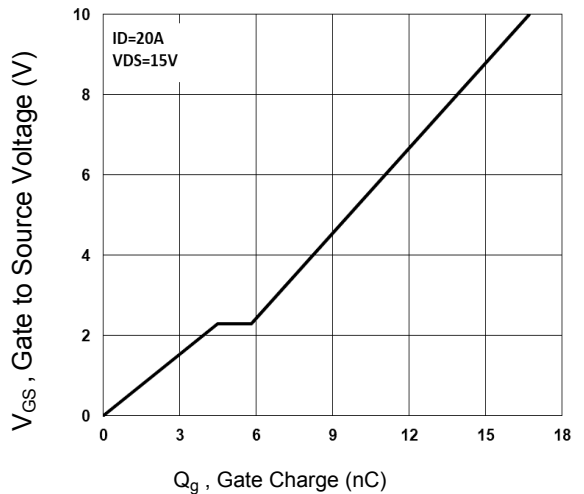
**Fig.1 Continuous Drain Current vs. Tc**



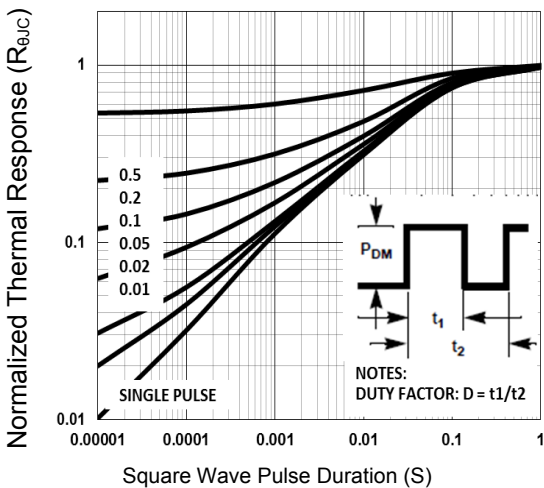
**Fig.2 Normalized  $R_{DS(ON)}$  vs.  $T_J$**



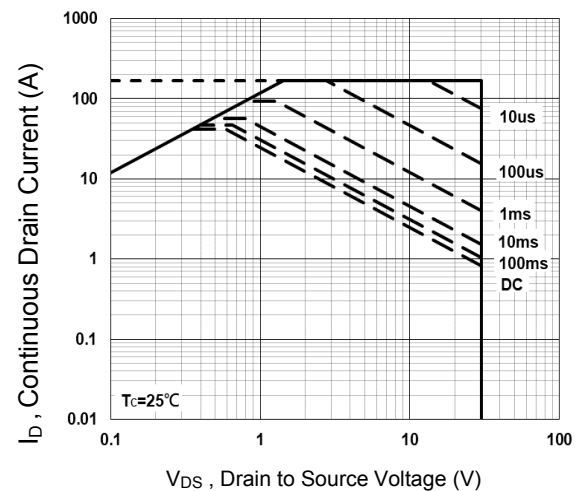
**Fig.3 Normalized  $V_{th}$  vs.  $T_J$**



**Fig.4 Gate Charge Waveform**



**Fig.5 Normalized Transient Impedance**



**Fig.6 Maximum Safe Operation Area**

**Typical Electrical and Thermal Characteristic Curves**

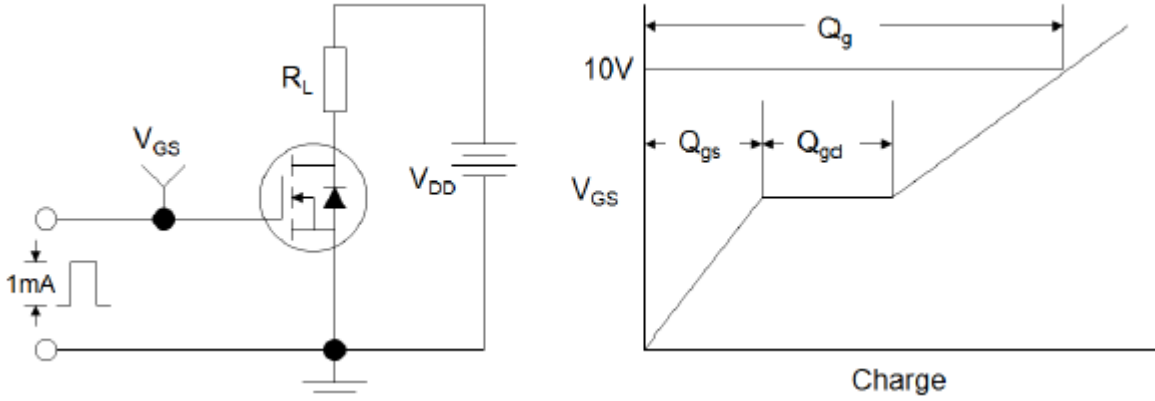


Figure 7. Gate Charge Test Circuit & Waveform

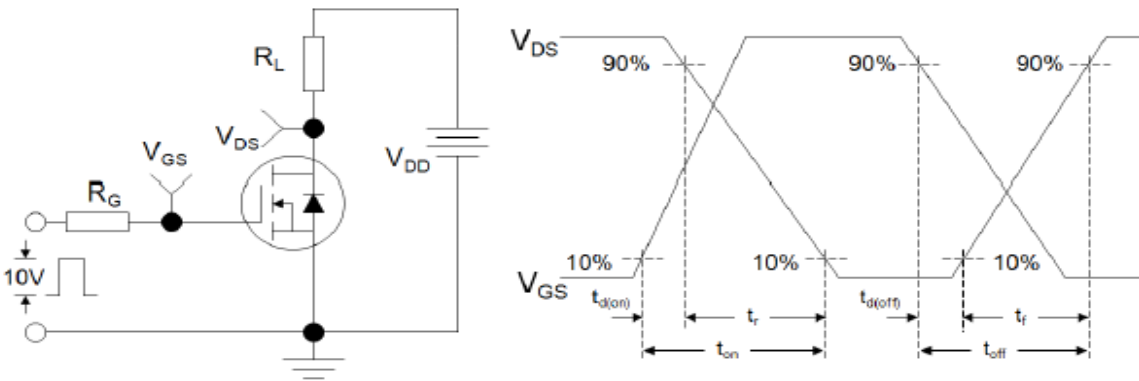


Figure 8. Resistive Switching Test Circuit & Waveforms

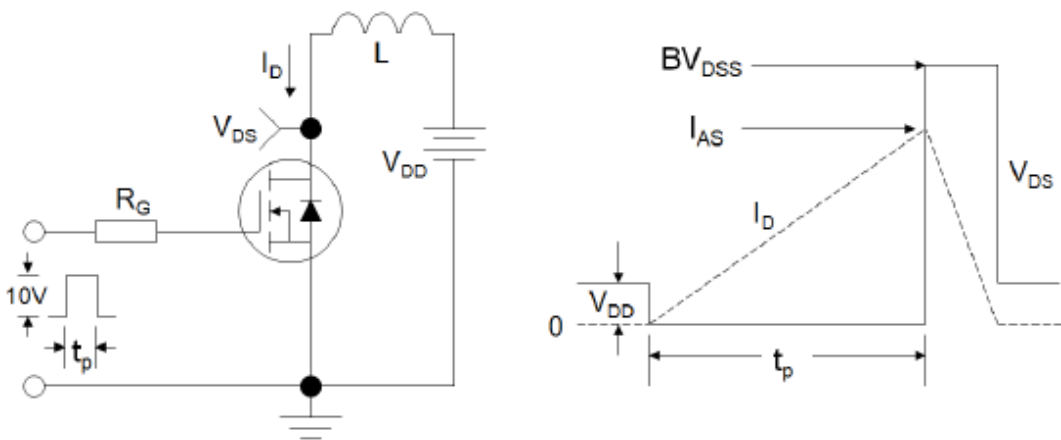
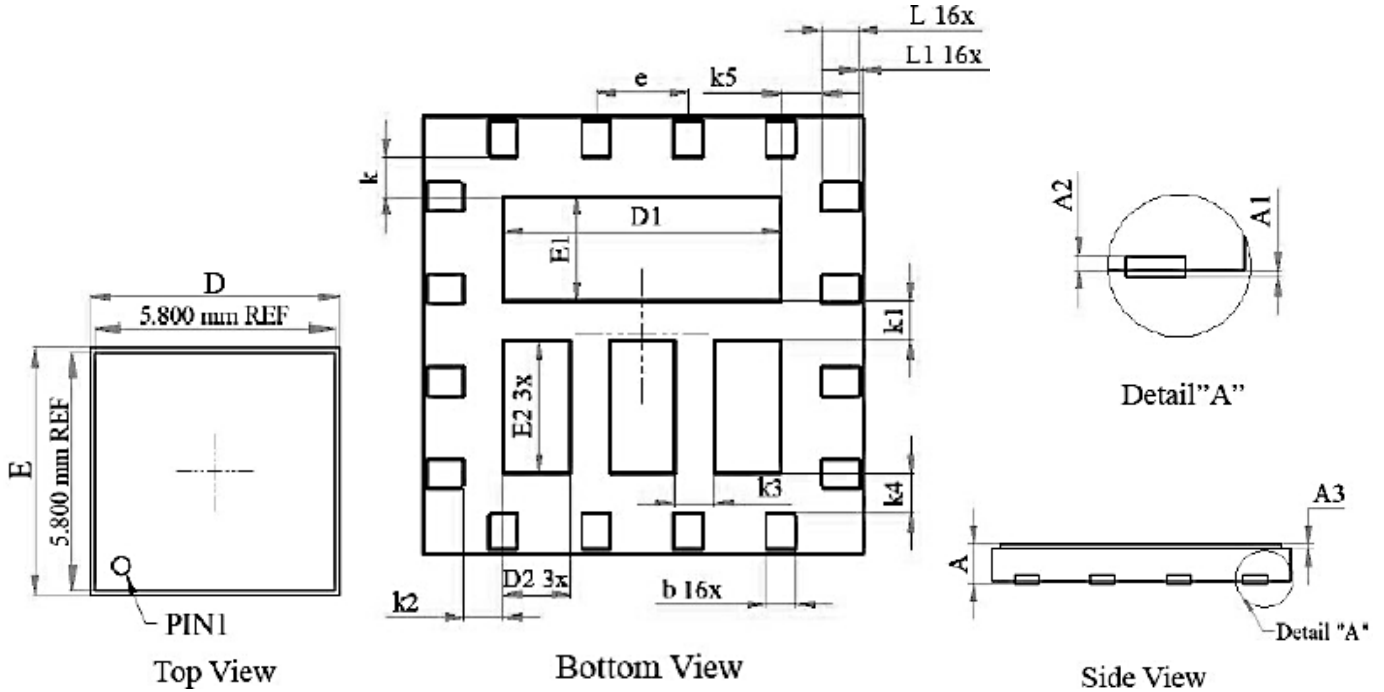


Figure 9.  $E_{AS}$  Circuit & Waveforms

**Package Outline Dimensions**

**DFN6x6**



Symbol	Dimensions In Millimeters			Symbol	Dimensions In Millimeters		
	MIN	Normal	MAX		MIN	Normal	MAX
A	0.530	-	0.600	b	0.350	0.400	0.450
A1	-	-	0.005	L	0.450	0.500	0.550
A2	0.030	-	0.100	L1	0.010	0.050	0.090
A3	0.050	-	0.100	k	0.550 REF		
D	5.900	6.000	6.100	k1	0.550 REF		
E	5.900	6.000	6.100	k2	0.550 REF		
D1	3.700	3.800	3.900	k3	0.550 REF		
E1	1.325	1.425	1.525	k4	0.550 REF		
D2	0.800	0.900	1.000	k5	0.550 REF		
E2	1.725	1.825	1.925	e	1.27 BSC		

**Recommended Pad Layout**

(Unit in MM)

